

<b>Notice of References Cited</b>	Application/Control No. 10/780,855	Applicant(s)/Patent Under Reexamination ZIRK ET AL.	
	Examiner Jason M Han	Art Unit 2875	Page 1 of 4

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,599,419	06-1952	STARK PHILLIP A	362/185
	B	US-2,705,279	03-1955	BERLINGER FREDERICK J	362/197
	C	US-4,364,104	12-1982	Holahan et al.	362/223
	D	US-4,669,186	06-1987	Liu, Nan T.	30/125
	E	US-4,918,775	04-1990	Leu, Ching-Baiu	7/168
	F	US-5,083,246	01-1992	Lambert, Jesse A.	362/471
	G	US-5,168,780	12-1992	Van Gennep, Jan	81/57.29
	H	US-5,169,225	12-1992	Palm, Bernhard	362/118
	I	US-5,199,874	04-1993	Campagnuolo et al.	434/11
	J	US-5,313,376	05-1994	McIntosh, Kirk W.	362/119
	K	US-5,331,741	07-1994	Taylor, Jr., William J.	30/158
	L	US-5,402,575	04-1995	Maxcy, Richard B.	30/123
	M	US-5,442,529	08-1995	Hoover, Richard P.	362/119

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/780,855	Applicant(s)/Patent Under Reexamination ZIRK ET AL.	
	Examiner Jason M Han	Art Unit 2875	Page 2 of 4

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,467,256	11-1995	Chen, Shun-fu	362/119
	B	US-5,474,452	12-1995	Campagnuolo, Carl J.	434/11
	C	US-5,588,732	12-1996	Sasaki et al.	362/10
	D	US-5,626,414	05-1997	Chen, Shun-fu	362/119
	E	US-5,652,587	07-1997	Liu, Chang-Jen	341/176
	F	US-5,653,525	08-1997	Park, Kyunghan	362/119
	G	US-5,727,319	03-1998	Myerchin et al.	30/123
	H	US-5,845,986	12-1998	Breen, William Charles	362/119
	I	US-5,878,500	03-1999	Emerson, Ernest R.	30/158
	J	US-5,947,789	09-1999	Chan, Albert T. W.	446/219
	K	US-6,027,224	02-2000	Schnell, Tim	362/119
	L	US-6,041,505	03-2000	Chen, Kun Chen	30/123
	M	US-6,142,769	11-2000	Walker, Trevor Lee	431/253

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/780,855	Applicant(s)/Patent Under Reexamination ZIRK ET AL.	
	Examiner Jason M Han	Art Unit 2875	Page 3 of 4

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,145,994	11-2000	Ng, Kelvin C.	362/119
	B	US-6,206,538	03-2001	Lemoine, David B.	362/119
	C	US-6,273,582	08-2001	Taggart et al.	362/119
	D	US-2001/0040801	11-2001	Krietzman et al.	362/200
	E	US-6,394,634	05-2002	Kitchin, Robert S.	362/477
	F	US-2002/0071270	06-2002	LAM, MAN KUEN	362/109
	G	US-2002/0075673	06-2002	Phelps, Mehrunissa N.	362/119
	H	US-6,434,829	08-2002	Chen, Shou Mao	30/123
	I	US-6,446,341	09-2002	Wang et al.	30/125
	J	US-2003/0223224	12-2003	Painsith et al.	362/119
	K	US-2004/0016058	01-2004	Gardiner et al.	7/119
	L	US-6,744,223	06-2004	Laflamme et al.	315/291
	M	US-6,749,318	06-2004	Palacios, Josue	362/119

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/780,855	Applicant(s)/Patent Under Reexamination ZIRK ET AL.	
	Examiner Jason M Han	Art Unit 2875	Page 4 of 4

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,761,470	07-2004	Sid, Alberto	362/233
	B	US-6,765,496	07-2004	Dayan, Mervin A.	340/903
	C	US-6,787,999	09-2004	Stimac et al.	315/51
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.